

Search Notes				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/667,004	CHAN ET AL.	
				Examiner	Art Unit	
				Frank W. Lu	1634	

SEARCHED			
Class	Subclass	Date	Examiner
435	6 7.1 9.1	5/12/2006	m
	183		
	2831 283.1		
	287.2		
436	94		
	501		
536	23.1 24.3 24.33		
	285.9		
530	300		
	350		
update		10/19/2006	m
update		4/12/2007	m
update		10/23/2007	m

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
STN	DATE	EXMR
East (see attached file)	5/17/2006	m
Inventor searches update	10/19/2006	m
update	4/12/2007	m
update	10/23/2007	m